

**Search Notes**

Application No.

10/620,446

Examiner

Stephen W. Smoot

Applicant(s)

TSENG ET AL.

Art Unit

2813

**SEARCHED**

Class	Subclass	Date	Examiner
438	4	11/10/2004	SWS
438	15	11/10/2004	SWS
438	17	11/10/2004	SWS
438	18	11/10/2004	SWS
438	107	11/10/2004	SWS
438	113	11/10/2004	SWS
438	122	11/10/2004	SWS
438	124	11/10/2004	SWS
438	126	11/10/2004	SWS
438	127	11/10/2004	SWS
438	460	11/10/2004	SWS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key Words: Chip Carrier - MCM, PCB, PWB, Memory Module, SIMM; Contact, Terminal, Lead, Electrode, Connector, Finger - Gold;	11/12/2004	S.W.S. SWS
Test, Evaluate - Repair, Replace, Restore; KGD - Known Good Die; Laser; Metal Shield - Heat Sink.	11/12/2004	S.W.S. SWS
Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	11/12/2004	S.W.S. SWS